

Data sheet acquired from Harris Semiconductor SCHS103C – Revised July 2003

CD40160B, CD40161B, CD40162B, CD40163B Types

CMOS Synchronous Programmable 4-Bit Counters

High-Voltage Types (20-Volt Rating)

 $\label{eq:cde} \textbf{CD40160B} - \textbf{Decade with Asynchronous}$

Clear

CD40161B — Binary with Asynchronous

Clear

CD40162B — Decade with Synchronous Clear

CD40163B — Binary with Synchronous Clear

■ CD40160B, CD40161B, CD40162B, and CD40163B are 4-bit synchronous programmable counters. The CLEAR function of the CD40162B and CD40163B is synchronous and a low level at the CLEAR input sets all four outputs low on the next positive CLOCK edge. The CLEAR function of the CD40160B and CD40161B is asynchronous and a low level at the CLEAR input sets all four outputs low regardless of the state of the CLOCK, LOAD, or ENABLE inputs. A low level at the LOAD input disables the counter and causes the output to agree with the setup data after the next CLOCK pulse regardless of the conditions of the ENABLE inputs.

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a carry output (COUT). Counting is enabled when both PE and TE inputs are high. The TE input is fed forward to enable COUT. This enabled output produces a positive output pulse with a

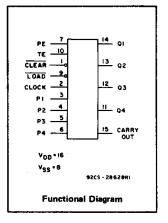
Features:

- Internal look-ahead for fast counting
- Carry output for cascading
- Synchronously programmable
- Clear asynchronous input (CD40160B, CD40161B)
- Clear synchronous input (CD40162B, CD40163B)
- Synchronous load control input
- Low-power TTL compatibility
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package-temperaature range): 1 V at V_{DD} = 5 V
 2 V at V_{DD} = 10 V
 2.5 V at V_{DD} = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

duration approximately equal to the positive portion of the Q1 output. This positive overflow carry pulse can be used to enable successive cascaded stages. Logic transitions at the PE or TE inputs may occur when the clock is either high or low.

The CD40160B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix). The CD40161B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

The CD40160B through CD40163B types are functionally equivalent to and pin-compatible with the TTL counter series 74LS160 through 74LS163 respectively.



Applications:

- Programmable binary and decade counting
- Counter control/timers
- Frequency dividing

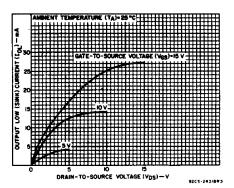
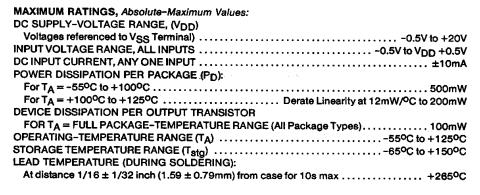


Fig. 1 – Typical output low (sink) current characteristics.



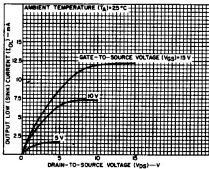


Fig. 2— Minimum output low (sink) current characteristics.

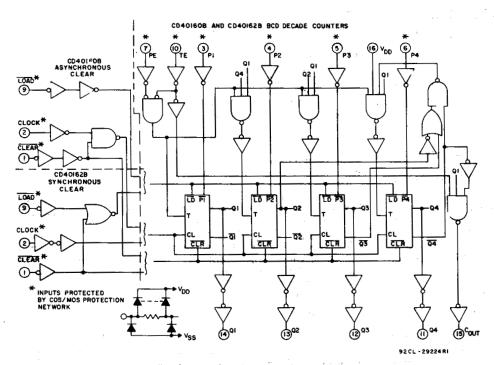


Fig. 3— Logic diagrams for CD40160B and CD40162B BCD decade counters.

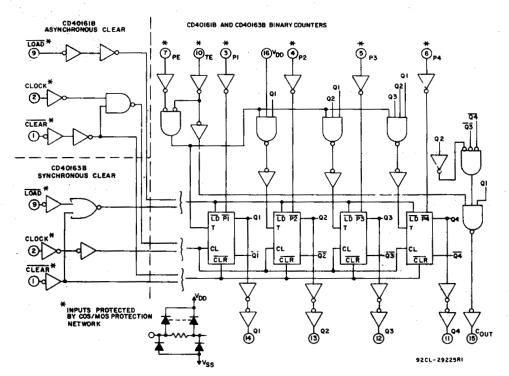


Fig. 4— Logic diagrams for CD40161B and CD40163B binary counters.

RECOMMENDED OPERATING CONDITIONS at $T_A = 25^{\circ}$ C, Except as Noted For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V _{DD}	LIM	LIMITS			
	(V)	MIN.	MAX.	UNITS		
Supply Voltage Range (Full T _A = Full Package - Temperature Range)	_	3	18	v		
Setup Time: t _{SU} Data to Clock	5 10 15	240 90 60	· -	ns		
Load to Clock	. 5 10 15	240 90 60	* *	ns		
PE or TE to Clock	5 10 15	340 140 100	1 1 1	П\$		
Clear to Clock (CD40162B, CD40163B)	5 10 15	340 140 100		ns		
All Hold Times, t _H	5 10 15	0 0 0	-	ns		
Clear Removal Time, t _{rem} (CD40160B, CD40161B)	5 10 15	200 100 70	<u>-</u>	ns		
Clear Pulse Width, t _{WL} (CD40160B, CD40161B)	5 10 15	170 70 50	-	ns		
Clock Input Frequency, fCL	5 10 15	_ _ _	2 5.5 8	MHz		
Clock Pulse Width, t _W	5 10 15	170 70 50	_ _ _	ns		
Clock Rise or Fall Time, t _F CL or t _f CL	5 10 15	-	200 70 15	μs		

TRUTH TABLE

CLOCK	CLR	LOAD	PE	TE	OPERATION
	1	0	х	х	PRESET
	1	1	0	х	NC
	1	1.,	×	0	NC
	1	1	1	1	COUNT
х	0	×	х	х	RESET (CD40160B, CD40161B)
	.0	×	х	х	RESET (CD40162B, CD40163B)
	1	x	х	х	NC (CD40162B, CD40163B)

1 - HIGH LEVEL

0 = LOW LEVEL

X = DON'T CARE

NC = NO CHANGE

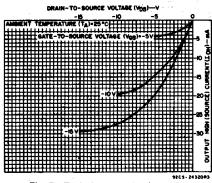


Fig. 5— Typical output high (source) current characteristics.

DRAIN-TO-SOURCE VOLTAGE (VDS)--V

Fig. 6— Minimum output high (source) current characteristics.

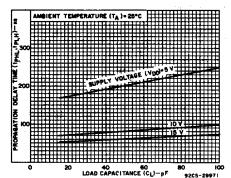


Fig. 7— Typical propagation delay time as a function of load capacitance (CLOCK to Q).

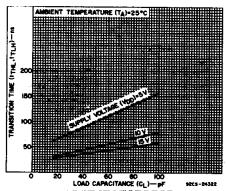


Fig. 8— Typical transition time as a function of load capacitance.

STATIC ELEC	RIGAL	UNAK!	-U1E	nialic	•				· ·		Т
CHARAC- TERISTIC	CON	CONDITIONS LIMITS AT INDIC. TEMPERATURES									
	v _o	VIN	V _{DD}		, , , , , , , , , , , , , , , , , , ,		A _g		+25		S
	(V)	(V)	(V)	55	-40	+85	+125	Min.	Тур.	Max.]
Quiescent		0,5	5	- 5	5	150	150	-	0.04	5	
Device	- , ;	0,10	10	10	10	300	300	+	0.04	10	اسم
Current, IDD Max.		0,15	15	20	20	600	600		0.04	20]
.ΩD:iaiaχ.	_ :	0,20	20	100	100	3000	3000	-	0.08	100	1.
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	. 1	- :	
(Sink) Current	0.5	0,10	10	1.6	1.5	1,1	0.9	: 1.3	2.6	<u> </u>	1
OL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_	
Output High .	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	- 1	_	mΑ
(Source) Current, IOH Min.	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	_	1
	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	1.
	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8		1
Output Voltage:	+	0,5	5		0.	-	0	0.05			
Low-Level,	-	0,10	10		0.	_	. 0	0.05	1		
V _{OL} Max.	-	0,15	15		. 0.	_	0	0.05	ľv		
Output .	_	0,5	5		. 4.	4.95	5	_	`		
Voltage: High-Level,	_	0,10	10		9.	9.95	10	_	1		
VOH Min.	_	0,15	15	in."	, 14.	.95		14.95	15	_	
Input Low	0.5,4.5	-	5			1.5			-:	1.5	
Voltage	1,9	1	10			3		-	-	3	1
V _{IL} Max.	1.5,13.5	1	15			Ţ		4	v		
Input High Voltage, VIH Min.	0.5,4.5	-	5			3.5		3.5	· _:	_	
	1,9	1	10	1		7		7		-	
	1.5,13.5	_	15			11		11		-	1
Input Current IN Max.	-	0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μА

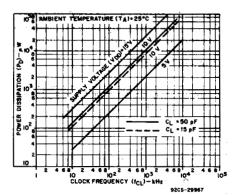


Fig. 9— Typical power dissipation as a function of CLOCK frequency.

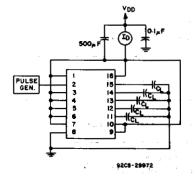


Fig. 10— Dynamic power dissipation test circuit.

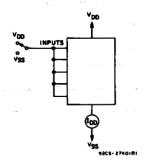


Fig. 11 — Quiescent-device-current test circuit

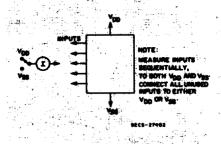


Fig. 12- Input-current test circuit.

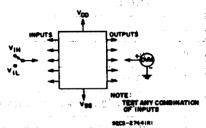
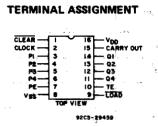


Fig. 13- Input-voltage test circuit.



DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C; Input t_r , t_f = 20 ns, C_L = 50 pF, R_L = 200 $k\Omega$

CHARACTERISTIC	TEST CONDITIONS		LIMITS ALL TYPES*				
	V _{DD} (V)	Min.	Тур.	Max.	UNITS		
CLOCK OPERATION				<u> </u>			
Propagation Delay Time, tpHL,tpLH Clock to Q	5 10 15	-	200 80	400 160	ns		
Clock to COUT	5 10 15		225 95 70	120 450 190 140	ns		
TE to COUT	5 10 15	-	125 55 40	250 110 80	ns		
Minimum Setup Time, tŞU Data to Clock	5 10 15	- - -	120 45 30	240 90 60	ns		
Load to Clock	5 10 15	<u>-</u> 	120 45 30	240 90 60	ns		
PE to TE to Clock	5 10 15		170 70 50	340 140 100	ns		
Minimum Hold Time, t _H	5 10 15			0 0 0	ns		
Transition Time, t _{THL} ,t _{TLH}	. err - 5 . Nogerier 10 15	- - -	100 50 40	200 100 80	ns		
Minimum Clock Pulse Width, t _W	5 10 15	_ _ _ 	85 35 25	170 70 50	n\$		
Maximum Clock Frequency, f _{CL}	5 10 15	2 5.5 8	3 8.5 12		MHz		
Maximum Clock Rise or Fall Time, [†] t _r CL, t _{fCL}	5 10 15	200 70 15	1 1 1	- -	μs		
CLEAR OPERATION							
Propagation Delay Time, tPHL (CD40160B, CD40161B) Clear to Q	5 10 15	-	250 110 80	500 220 160	n\$		
Minimum Setup Time, tsu (CD40162B, CD40163B) Clear to Clock	5 .10 .15		170 70 50	340 140 100	ns		
Minimum Hold Time, t _H (CD40162B, CD40163B) Clear to Clock	5 10 15	-	, <u>-</u> -	000	ns		
Minimum Clear Removal Time, t _{rem} (CD40160B, CD40161B)	5 10 15		100 50 35	200 100 70	ns		
Minimum Clear Pulse Width, twL (CD40160B, CD40161B)	5 10 15	-	85 35 25	170 70 50	ns		

Control of the contro

^{*} Except as noted.
† If more than one unit is cascaded in the parallel clocked application, t.CL should be made less than or equal to the sum of the fixed propagation delay at 50 pF and the transition time of the carry output driving stage for the estimated capacitive load.

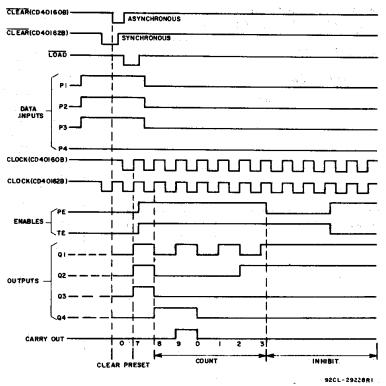


Fig. 14— Timing diagram for CD40160B, CD40162B.

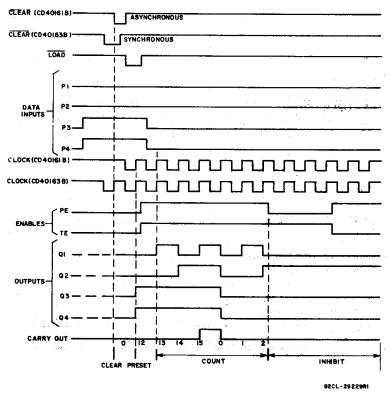


Fig. 15- Timing diagram for CD40161B, CD40163B.

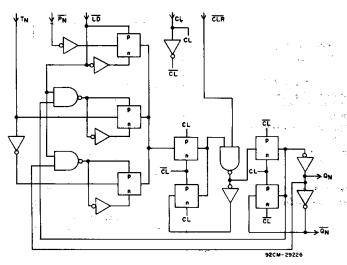
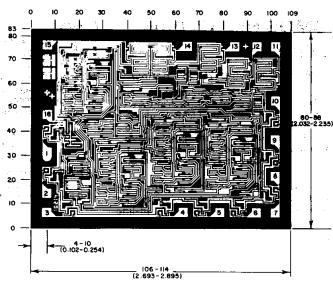


Fig. 16— Detail of flip-flops of CD40160B and CD40161B (asynchronous clear).



Dimensions and pad layout for CD40160BH. Dimensions and pad layout for CD40161BH, CD40162BH, and CD40163BH are identical.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).

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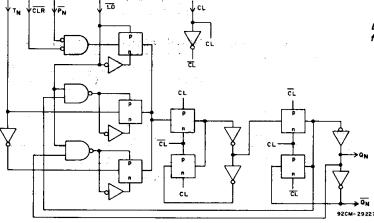


Fig. 17— Detail of flip-flops for CD40162B and CD40163B (synchronous clear).

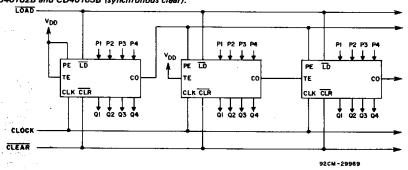


Fig. 18 - Cascaded counter packages in the parallel-clocked mode.

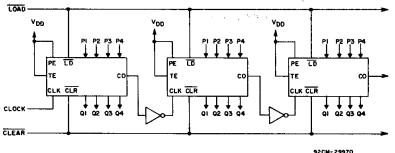


Fig. 19 — Cascaded counter packages in the ripple-clocked mode.

PACKAGE OPTION ADDENDUM

www.ti.com 11-Nov-2009

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD40160BF3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
CD40161BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD40161BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD40161BF3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
CD40161BNSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD40161BNSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD40161BNSRG4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD40161BPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD40161BPWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD40161BPWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PACKAGE MATERIALS INFORMATION

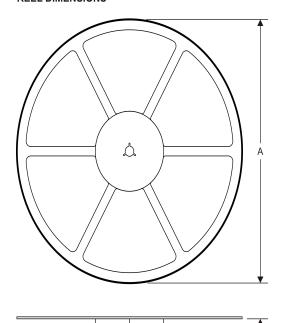
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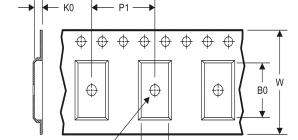
TAPE DIMENSIONS

Cavity

TAPE AND REEL INFORMATION

REEL DIMENSIONS





◆ A0 **▶**

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD40161BNSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD40161BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD40161BNSR	SO	NS	16	2000	367.0	367.0	38.0
CD40161BPWR	TSSOP	PW	16	2000	367.0	367.0	35.0

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE

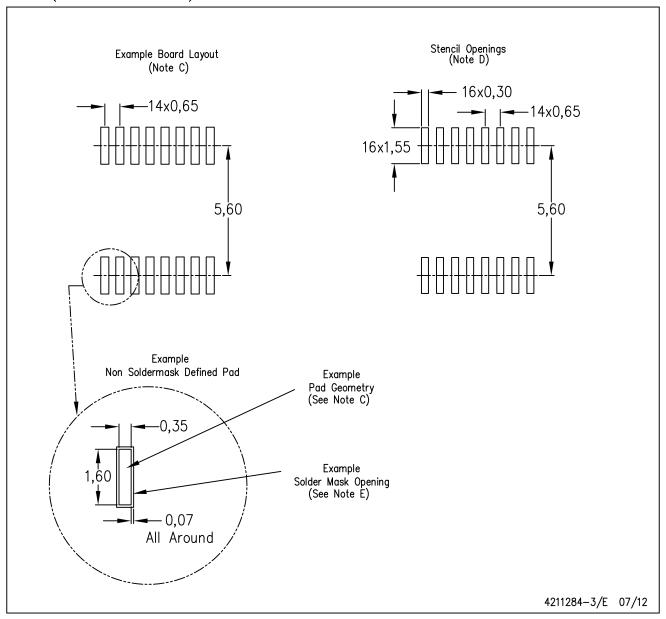


- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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